

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under  
Reexamination

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Examiner

Mark Tsidulko

Art Unit

2875

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**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-2002/0084890	07-2002	Guerrieri et al.	340/332
B	US-6,394,622	05-2002	Macek, David W.	362/228
C	US-			
D	US-			
E	US-			
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**FOREIGN PATENT DOCUMENTS**

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